

650V 4A N-Channel Enhancement Mode Power MOSFET

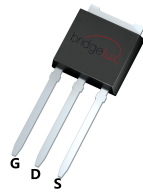
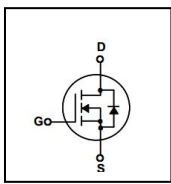
General Description

BXP4N65 is Bridgelux high voltage MOSFET family based on advanced planar stripe DMOS technology. This advanced MOSFET family has optimized on-state resistance, and also provides superior switching performance and higher avalanche energy strength. This device family is suitable for high efficiency switch mode power supplies.

FEATURES

- $R_{DS(ON)} \leq 2.8 \Omega$ @ $V_{GS}=10V, I_D=2A$
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- Fast switching capability
- Lead free product is acquired

SYMBOL



TO-251L



TO-252



TO-220



TO-220F

ASSEMBLY MESSAGE

| Product Name | Marking | Package | Packaging |
|--------------|----------|---------|-----------|
| BXP4N65U | BXP4N65U | TO-251L | Tube |
| BXP4N65D | BXP4N65D | TO-252 | Tube/Reel |
| BXP4N65P | BXP4N65P | TO-220 | Tube |
| BXP4N65F | BXP4N65F | TO-220F | Tube |

ABSOLUTE MAXIMUM RATINGS ($T_C=25^\circ\text{C}$ unless otherwise noted)

| Parameter | Symbol | Rating | | | Unit |
|-----------------------------------|--|------------|----------|----------|---------------------|
| | | BXP4N65U/D | BXP4N65P | BXP4N65F | |
| Drain-Source Voltage | V_{DSS} | 650 | | | V |
| Drain Current | Continuous ($T_C = 25^\circ\text{C}$) | 4 | | | A |
| | Continuous ($T_C = 100^\circ\text{C}$) | 2.5 | | | A |
| Drain Current | Pulsed (Note1) | 16 | | | A |
| Gate-Source Voltage | V_{GSS} | ± 30 | | | V |
| Avalanche Energy | Single Pulse (Note2) | 220 | | | mJ |
| | Repetitive (Note1) | 15 | | | mJ |
| Avalanche Current (Note1) | I_{AR} | 4 | | | A |
| Peak Diode Recovery dv/dt (Note3) | dv/dt | 5 | | | V/ns |
| Power Dissipation (Note 2) | $T_C = 25^\circ\text{C}$ | 77 | 98 | 37 | W |
| | Derate above 25°C | 0.62 | 0.79 | 0.3 | W/ $^\circ\text{C}$ |
| Maximum Junction Temperature | T_J | 150 | | | $^\circ\text{C}$ |
| Storage Temperature Range | T_{STG} | -55 to 150 | | | $^\circ\text{C}$ |

Note: 1. Repetitive Rating: Pulse width limited by maximum junction temperature

2. $L=27.5\text{mH}$, $I_{AS}=4.0\text{A}$, $V_{DD}=50\text{V}$, $R_G=25 \Omega$, Starting $T_J = 25^\circ\text{C}$

3. $I_{SD} \leq 4.0\text{A}$, $di/dt \leq 300\text{A}/\mu\text{s}$, $V_{DD} \leq BV_{DSS}$, Starting $T_J = 25^\circ\text{C}$

THERMAL CHARACTERISTICS

| Parameter | Symbol | Max. | | | Unit |
|---|-----------------|------------|----------|----------|-------------------------------|
| | | BXP4N65U/D | BXP4N65P | BXP4N65F | |
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 1.62 | 1.27 | 3.35 | $^{\circ}\text{C} / \text{W}$ |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 110 | 62 | 120 | $^{\circ}\text{C} / \text{W}$ |

ELECTRICAL CHARACTERISTICS ($T_J=25^{\circ}\text{C}$, unless otherwise Noted)

| Parameter | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
|--|--------------------------------|---|------|------|------|----------------------|
| OFF CHARACTERISTICS | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{GS}=0V, I_D=250\mu A$ | 650 | | | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=650V, V_{GS}=0V$ | | | 1 | μA |
| | | $V_{DS}=520V, T_C = 125^{\circ}\text{C}$ | | | 100 | μA |
| Gate-Body Leakage Current, Forward | I_{GSS} | $V_{GS}=30V$ | | | 100 | nA |
| Gate-Body Leakage Current, Reverse | | $V_{GS}=-30V$ | | | -100 | nA |
| Breakdown Voltage Temperature Coefficient | $\Delta BV_{DSS} / \Delta T_J$ | $I_D = 250 \mu A$ | | 0.62 | | $V/^{\circ}\text{C}$ |
| ON CHARACTERISTICS | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2 | | 4 | V |
| Drain-Source On-State Resistance | $R_{DS(ON)}$ | $V_{GS}=10V, I_D=2A$ | | 2.4 | 2.8 | Ω |
| Forward Transconductance (Note4) | g_{FS} | $V_{DS} = 50V, I_D = 2A$ | | 2.5 | | S |
| DYNAMIC PARAMETERS | | | | | | |
| Input Capacitance | C_{ISS} | $V_{DS}=25V, V_{GS}=0V,$ $f=1.0\text{MHz}$ | | 545 | | pF |
| Output Capacitance | C_{OSS} | | | 54 | | pF |
| Reverse Transfer Capacitance | C_{RSS} | | | 5 | | pF |
| SWITCHING PARAMETERS | | | | | | |
| Turn-ON Delay Time | $t_{D(ON)}$ | $V_{DD}=325V, I_D=4 A, V_{GS} = 10V, R_G=10\Omega$ (Note4,5) | | 11 | | ns |
| Turn-ON Rise Time | t_R | | | 25 | | ns |
| Turn-OFF Delay Time | $t_{D(OFF)}$ | | | 32.5 | | ns |
| Turn-OFF Fall-Time | t_F | | | 7 | | ns |
| Total Gate Charge(Note5) | Q_G | $V_{DS} = 520V, V_{GS} = 10V, I_D = 4A$ (Note4,5) | | 13 | | nC |
| Gate Source Charge | Q_{GS} | | | 3.4 | | nC |
| Gate Drain Charge | Q_{GD} | | | 7 | | nC |
| SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS | | | | | | |
| Drain-Source Diode Forward Voltage | V_{SD} | $I_S=4A, V_{GS}=0V$ | | | 1.4 | V |
| Diode Continuous Forward Current | I_S | | | | 4 | A |
| Pulsed Drain-Source Current | I_{SM} | | | | 16 | A |
| Reverse Recovery Time | t_{RR} | $V_{GS} = 0 V, I_{SD} = 4A$ | | 510 | | ns |
| Reverse Recovery Charge | Q_{RR} | $di/dt=100 A/\mu s$ (Note4,5) | | 2.5 | | μC |

Note: 4. Pulse Test : Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$

5. Essentially independent of operating temperature

TYPICAL CHARACTERISTICS

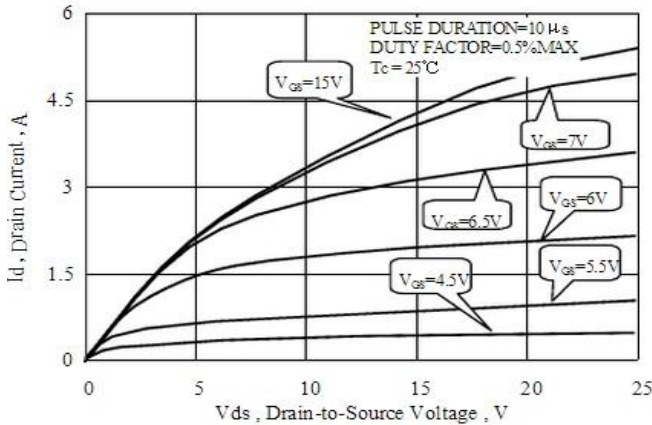


Figure 1. Typical Output Characteristics

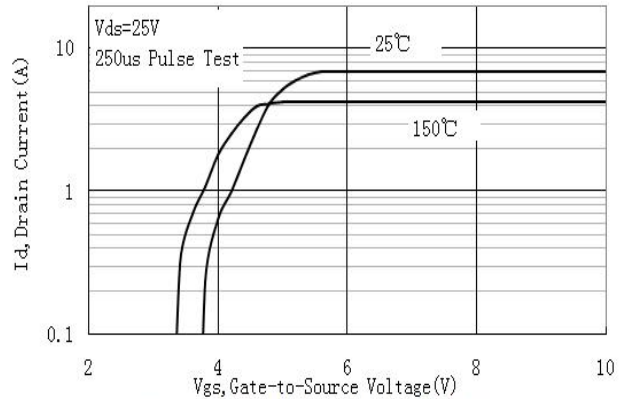


Figure 2. Typical Transfer Characteristics

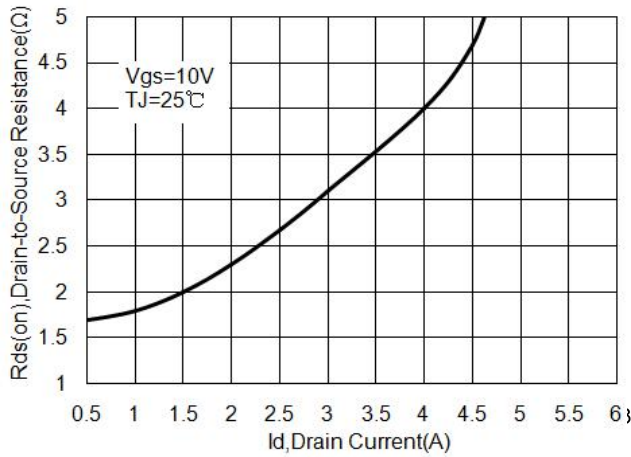


Figure 3. On-Resistance versus Drain Current

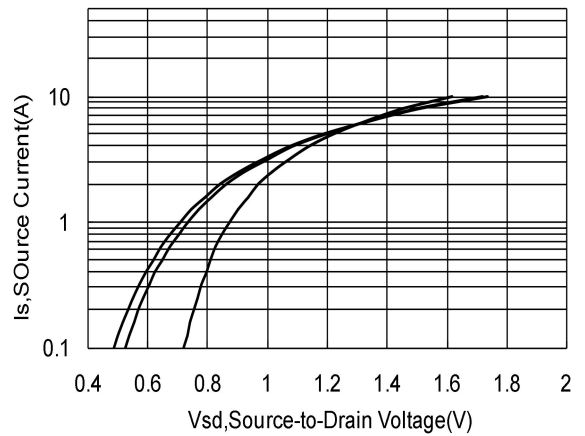


Figure 4. Diode Forward Voltage versus Current

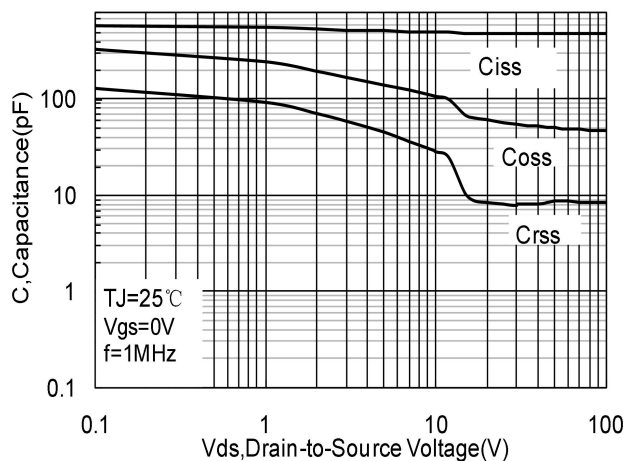


Figure 5. Typical Capacitance vs. Drain-to-Source Voltage

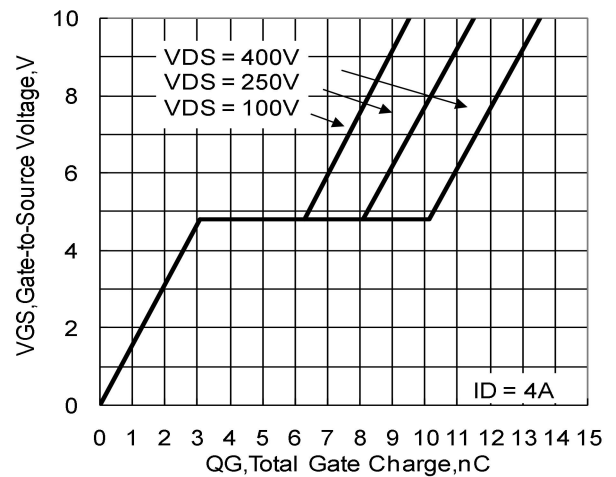


Figure 6. Typical Gate Charge vs. Vgs

TYPICAL CHARACTERISTICS(Cont.)

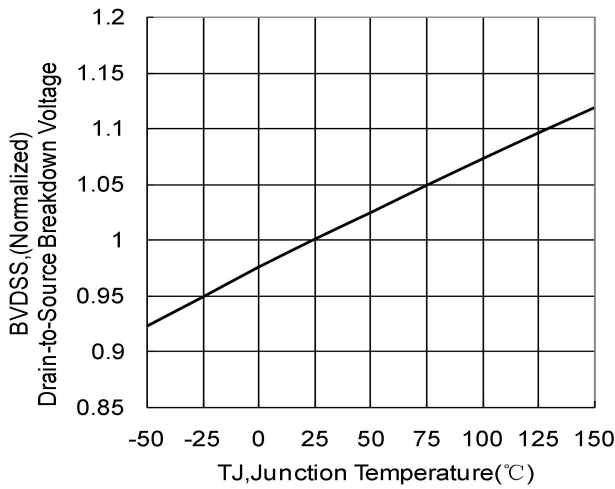


Figure 7. Bvdss Variation with Temperature

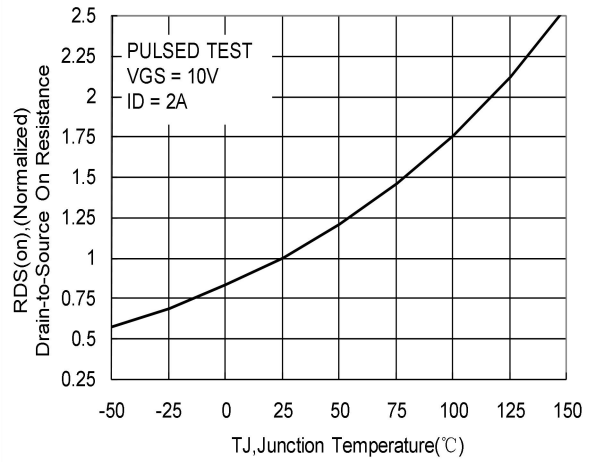


Figure 8. On-Resistance Variation with Temperature

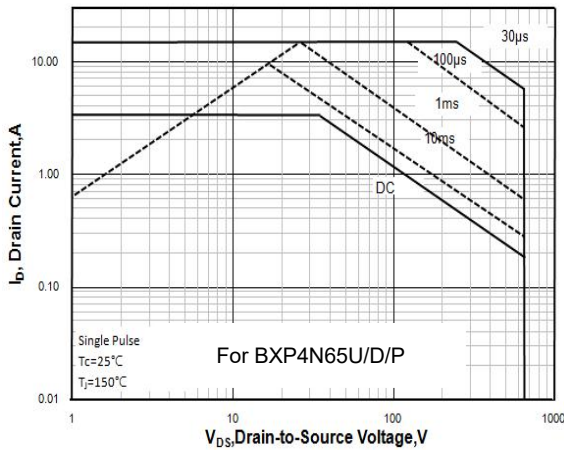


Figure 9. Maximum Safe Operating Area

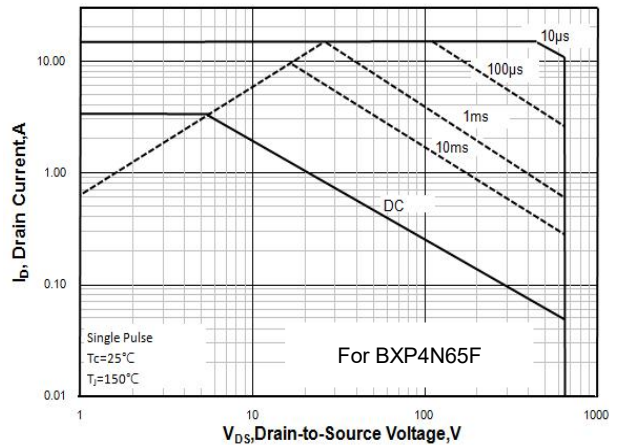


Figure 9. Maximum Safe Operating Area

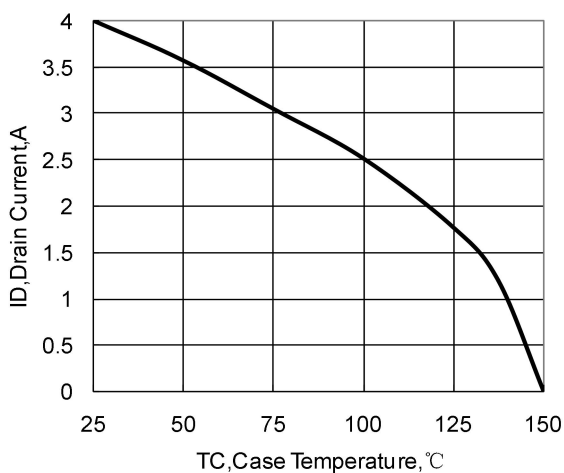
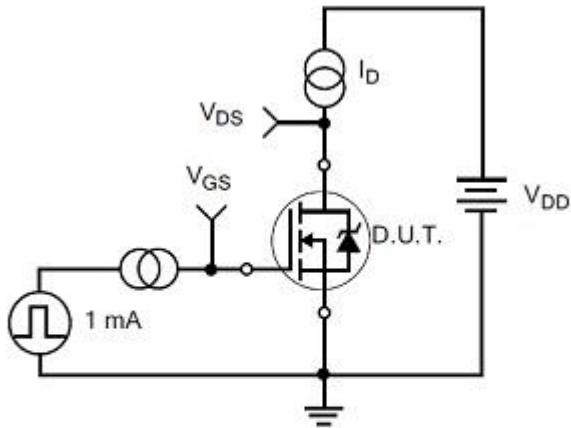
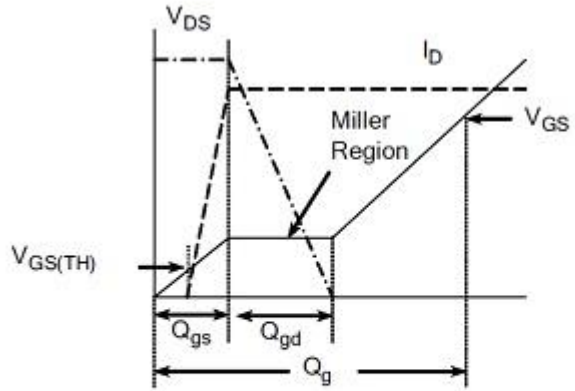


Figure 10. Maximum Continuous Drain Current vs Case Temperature

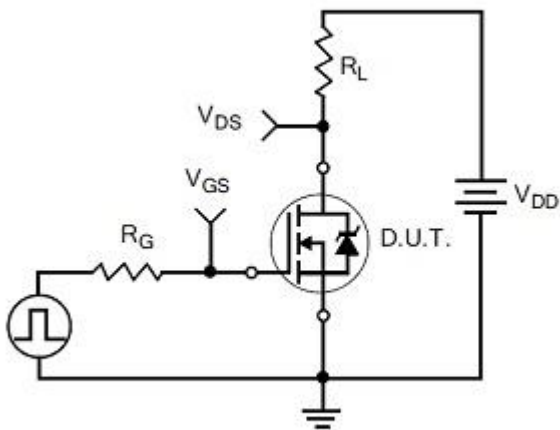
TEST CIRCUITS AND WAVEFORMS



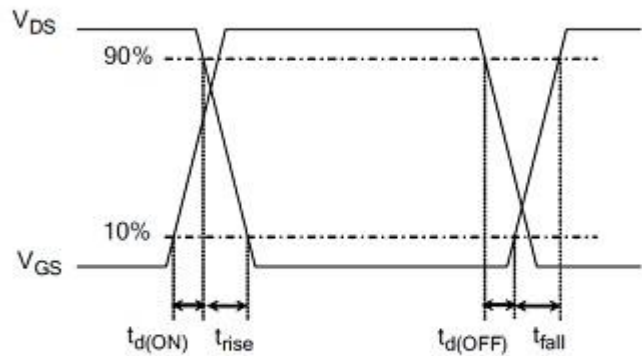
Gate Charge Test Circuit



Gate Charge Waveform

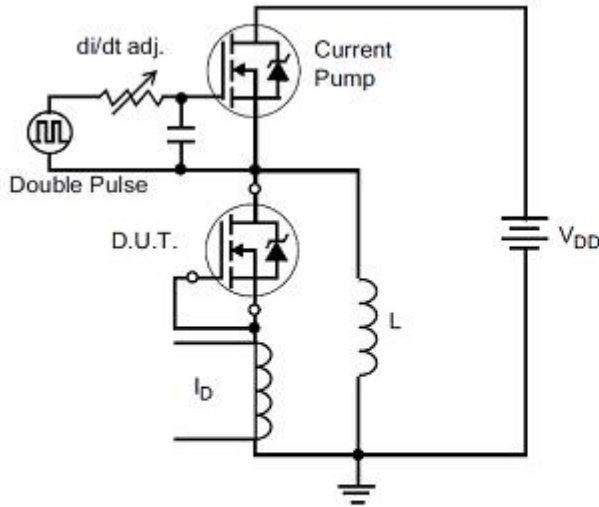


Resistive Switching Test Circuit

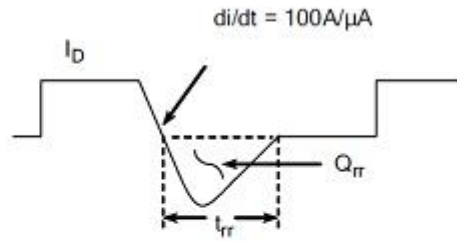


Resistive Switching Waveforms

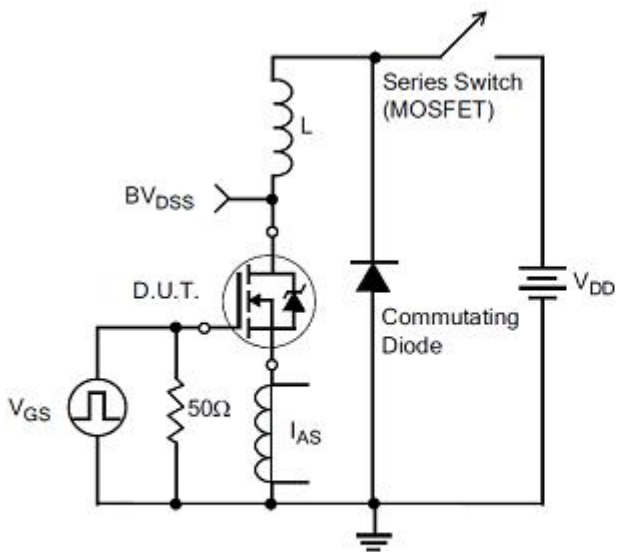
TEST CIRCUITS AND WAVEFORMS(Cont.)



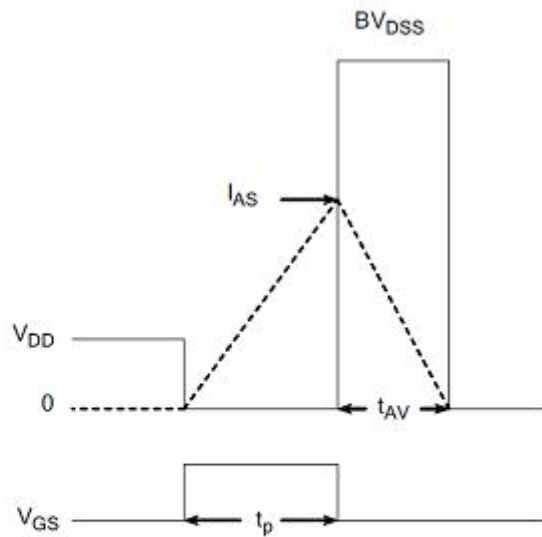
Diode Reverse Recovery Test Circuit



Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit



$$E_{AS} = \frac{I_{AS}^2 L}{2}$$

Unclamped Inductive Switching Waveforms

Revision history

Document revision history

| Date | Revision | Changes |
|-------------|----------|----------------------|
| 15-Oct-2020 | 1.0 | First release |
| 10-Nov-2021 | 1.1 | Update layout format |
| 4-Jan-2022 | 1.2 | Update parameter |
| | | |

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